

Summer-2019 UM-SJTU JI Ve311 Homework #5

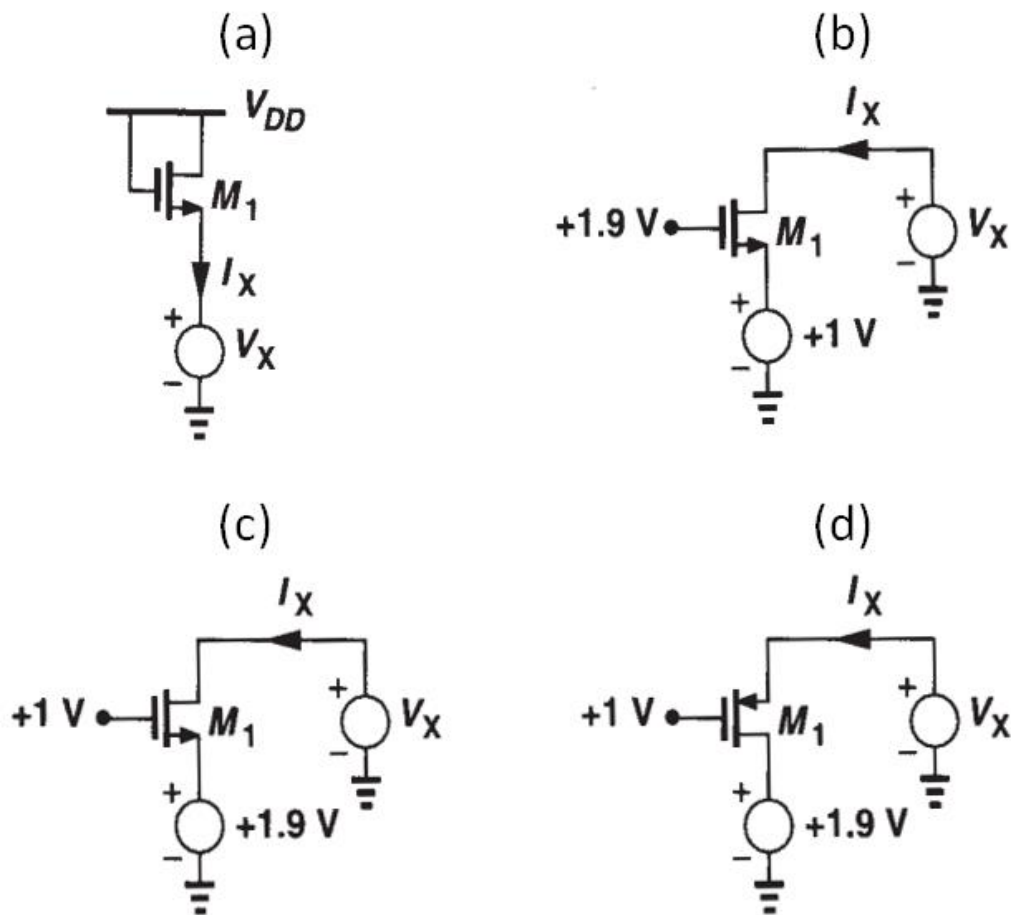
Instructor: Dr. Chang-Ching Tu

Due: 10:00 am, July 04, 2019 (Thursday) in class

Note:

- (1) Please use A4 size papers.
- (2) Please use the SPICE model on page 3 for simulation and calculation.

1. [MOSFET DC Biasing, 60%] Assuming $\gamma = \lambda = 0$ and $W_{\text{drawn}} / L_{\text{drawn}} = 30 \mu\text{m} / 5 \mu\text{m}$, sketch I_X and the transconductance (g_m) of M_1 as a function of V_X increasing from 0 V to $V_{DD} = 5 \text{ V}$.



2. [MOSFET Small-Signal Model] Assume $W_{\text{drawn}} / L_{\text{drawn}} = 10 \mu\text{m} / 2 \mu\text{m}$.
- (a) [20%] Use Pspice to plot the drain current of a NMOS as a function of V_{DS} increasing from 0 V to 5 V, at $V_{\text{GS}} = 1 \text{ V}$, 1.5 V and 2 V. Label the off, triode and saturation regions for each curve. Derive r_o from each curve in the saturation region and compare it with hand-calculation result.
- (b) [20%] Use Pspice to plot the drain current of a NMOS as a function of V_{GS} increasing from 0 V to 3 V, at $V_{\text{DS}} = 5 \text{ V}$. Derive g_m from the curve when $V_{\text{GS}} = 2 \text{ V}$ and compare it with hand-calculation result.

NMOS Model

LEVEL = 1	VTO = 0.7	GAMMA = 0.45	PHI = 0.9
NSUB = 9e+14	LD = 0.08e-6	UO = 350	LAMBDA = 0.1
TOX = 9e-9	PB = 0.9	CJ = 0.56e-3	CJSW = 0.35e-11
MJ = 0.45	MJSW = 0.2	CGDO = 0.4e-9	JS = 1.0e-8

PMOS Model

LEVEL = 1	VTO = -0.8	GAMMA = 0.4	PHI = 0.8
NSUB = 5e+14	LD = 0.09e-6	UO = 100	LAMBDA = 0.2
TOX = 9e-9	PB = 0.9	CJ = 0.94e-3	CJSW = 0.32e-11
MJ = 0.5	MJSW = 0.3	CGDO = 0.3e-9	JS = 0.5e-8

VTO: threshold voltage with zero V_{SB} (unit: V)

GAMMA: body effect coefficient (unit: $V^{1/2}$)

PHI: $2\Phi_F$ (unit: V)

TOX: gate oxide thickness (unit: m)

NSUB: substrate doping (unit: cm^{-3})

LD: source/drain side diffusion (unit: m)

UO: channel mobility (unit: $cm^2/V/s$)

LAMBDA: channel-length modulation coefficient (unit: V^{-1})

CJ: source/drain bottom-plate junction capacitance per unit area (unit: F/m^2)

CJSW: source/drain sidewall junction capacitance per unit length (unit: F/m)

PB: source/drain junction built-in potential (unit: V)

MJ: exponent in CJ equation (unitless)

MJSW: exponent in CJSW equation (unitless)

CGDO: gate-drain overlap capacitance per unit width (unit: F/m)

CGSO: gate-source overlap capacitance per unit width (unit: F/m)

JS: source/drain leakage current per unit area (unit: A/m^2)

Vacuum permittivity (ϵ_0) = 8.85×10^{-12} (F / m)

Silicon oxide dielectric constant (ϵ_r) = 3.9